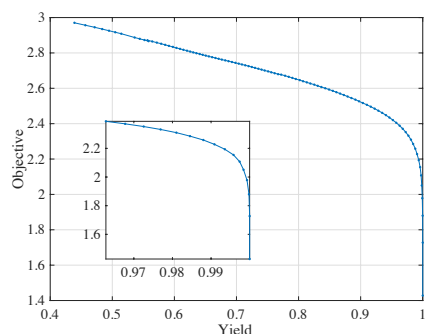




## What limits the standard yield optimization?

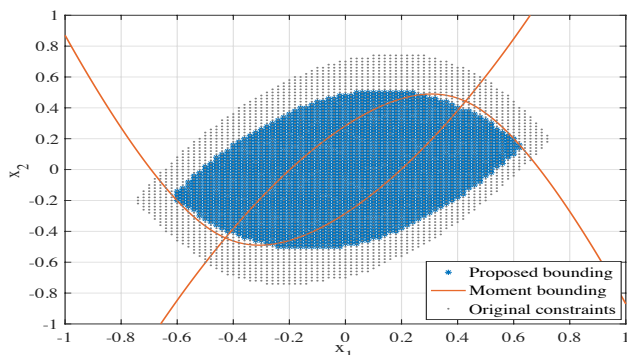


Only yield-driven  
↓  
Over-conservative design

## Chance-constrained yield-aware optimization

$$\begin{aligned} \max_{\mathbf{x} \in \mathbf{X}} \quad & \mathbb{E}_{\xi} [f(\mathbf{x}, \xi)] \\ \text{s.t.} \quad & \mathbb{P}_{\xi} (y_i(\mathbf{x}, \xi) \leq u_i) \geq 1 - \epsilon_i, \forall i = [n]. \end{aligned}$$

Optimizing the design metric while certifying the guarantee on probabilistic yield constraints



Two key components:

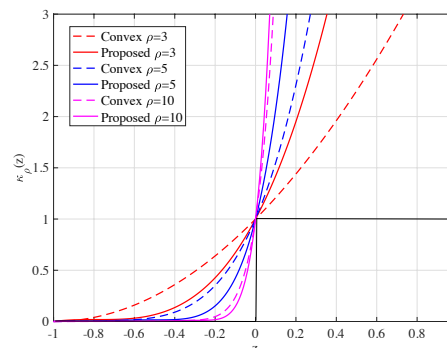
- Performance modeling
- Tractable stochastic programming algorithm

## Our PoBO solution

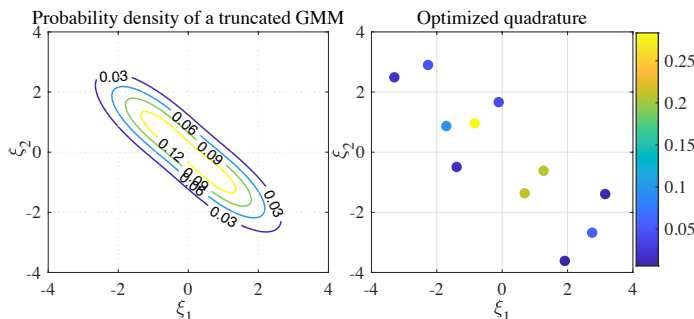
- ❖ An optimal polynomial kinship function to upper bound the probabilistic constraints

$$\mathbb{P}_{\xi} (y_i(\mathbf{x}, \xi) > u_i) \leq \int \kappa_{\rho} (y_i(\mathbf{x}, \xi) - u_i) \mu(\xi) d\xi \leq \epsilon_i$$

$\kappa(\cdot)$  solved by semi-definite programming, aiming to make the upper bound tight



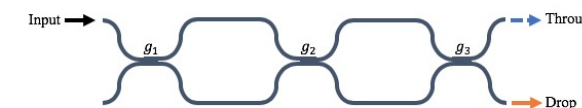
## Efficient numerical implementation



Numerical integration by quadrature points, free-lunch from performance modeling

- ❖ Globally optimal design via polynomial optimization solver

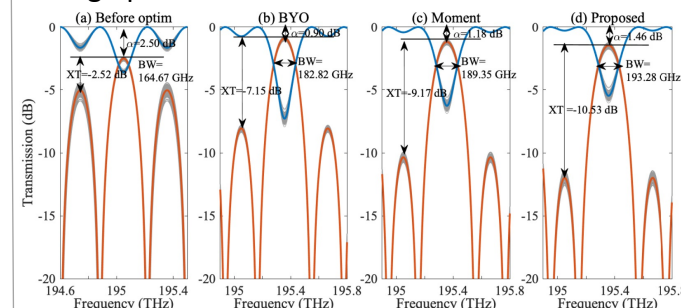
## Case study on Mach-Zehnder interferometer



Design task:

$$\begin{aligned} \max_{\mathbf{x} \in \mathbf{X}} \quad & \mathbb{E}_{\xi} [\text{BW}(\mathbf{x}, \xi)] \\ \text{s.t.} \quad & \mathbb{P}_{\xi} (\text{XT}(\mathbf{x}, \xi) \leq \text{XT}_0) \geq 1 - \epsilon_1, \\ & \mathbb{P}_{\xi} (\alpha(\mathbf{x}, \xi) \leq \alpha_0) \geq 1 - \epsilon_2. \end{aligned}$$

Design performance:



## Better performance + smaller constraint gap Δ

Risk $\epsilon$	Method	$\mathbb{E}[\text{BW}]$	$\Delta_1$ (%)	$\Delta_2$ (%)	Yield (%)	# Simulation
0.07	Moment [2]	187.02	7.53	7.53	100	35
	PoBO	192.1	7.53	7.2	99.7	35
0.1	Moment [2]	189.35	11.11	11.11	100	35
	PoBO	193.28	11.11	4.22	93.8	35
N/A	BYO [3]	182.82	N/A	N/A	100	2020

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## Reference

- [1] This work has been accepted by TCAD, arXiv: 2107.12593
- [2] Cui et al. TCAD 2020
- [3] Wang et al. DAC 2017